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Henrik Lemke :: SwissFEL :: Paul Scherrer Institut

Experimental Station B Ultrafast Diffraction

SwissFEL User Kick-off Meeting, 06.12.2016



ESB location in ARAMIS Experimental area





Team (ESB Endstation)

G. Ingold: BL Scientist / FEMTO group leader
P. Beaud: Senior Scientist (50% FEMTO)
H. Lemke: BL Scientist (formerly: LCLS)
A. Oggenfuss: Technician
J. Rittmann: Postdoctoral Researcher
P. Böhler: Mech. Design/Engineering (PSI AMI
A. Keller: Mech. Design/Engineering (PSI AMI)
Y. Deng: Laser Scientist (SwissFEL Laser Group
T. Zamofing: Software (PSI Controls Group)

In collaboration (ESB Instrument):

SwissFEL Management	<u>Beam</u>
R. Abela	Claud
B. Patterson	Christ
L. Patthey	
	Laser
X-ray Diagnostics	Ch. Er
P. Juranic	Ch. Ha
J. Rehanek	M. Div
DAO	Detec
L. Sala	A. Mo
S. Ebner	B. Sch
X-ray Optics Group	<u>Mech</u>
U. Flechsig	P. Wie
R. Follath	

A. Jäggi

<u>Beamline</u> Claude Pradervand Christoph Hess

<u>Laser Group</u> Ch. Erny Ch. Hauri M. Divall

<u>Detectors</u> A. Mozzanica B. Schmidt

Mech. Engineering P. Wiegand

Synchronization S. Hunziker



Beam trajectories



Conclusions

The ESB station is ...

... specialized for solid state pump/probe experiments

... flexible for implementation of larger equipment

(e.g. ESB-MX/Pedrini).



Example: Correlated electron systems







Beaud et al. PRL 103, 155702 (2009).

Material phases with very different electronic and magnetic properties through complex interplay of electronic and ionic structure.



Correlated material \rightarrow correlated Mechanism

Correlated Structure suggests switching mechanism through interaction between degrees of freedom



Time information can unravel process cascades/dependencies





Causality in mechanism cascade can be detected by selective excitation and probing of specific DOFs





Example Manganite – resonant diffraction



Beaud et al., Nature Materials 13, 923-927 (2014)



Experimental requirements

- Conditioning of sample system
- Selective manipulation of different DOFs
- Selective sensitivity to different DOFs
- Sufficient time resolution to separate

process cascades







Controlling sample Condition: T, P, B

Compromise between sample degrees of freedom and sample environment

- Cryostats
- High B-field superconducting magnets
- Vacuum chambers
- High-P setups





Requirement of flexible platform

Examples from

P09 and P01, PETRA III (DESY)



Flexible Diffractometer options

Exchange Modules Sample μ rotation High load к sample arm goniometer non-magn. Base **Platforms** Sample θ Sample θ 2θ arm Detector $\delta \& \gamma$ Beam positioning table (3 DOF) Beam positioning table







Thierry Zamofing

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Infrastructure for resonant diffraction at low Temperatures





Gerhard Ingold Alex Oggenfuss



LN2 / He cryo blower (30-100 K) e.g. with Kappa arm



Pump laser: wide range of excitation conditions



Ti:Sa laser System > 20 mJ, < 30 fs @ 100 Hz ~ 50/50 Timing/experiment

OPA: Topas HE

0.72 0.7

0.68

-500

0

Delay

500

Yunpei Deng

1100 nm			
ca. 1 mJ			
ca. 40 fs			

- < 15'000 nm ca. 10 µJ
- < 100 fs



Paul Beaud Christian Erny



1 – 10 THz

> 1 MV/cm, ca. 10 µJ

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Optimized Energy range: Pink pulse energy, BW (expected): Beam profile: 4.5-12.4 keV 1 mJ / pulse, <1% BW 300-600 μm (FWHM)

Single X-ray beam trajectory



Distance from end of undulator (m)



Rolf Follath Uwe Flechsig

Upgrades

- 1. Refractive optics
- 2. Harmonic rejection
- 3. Phase retarder

R. Follath et al. Proc. SRI (2015)

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Detection



Polarisation analyzer



Diffractometer with double detector arm



16M



Aldo Mozzanica

Module size	80x40 mm ²
Px size	75x75 μm²
Dyn. Range	10 ⁴ @ 12 keV

Patrick Suter



Sample - detector distances: -0.5 – 3 m



Pump/probe geometry / Timing diagnostics

6 DOF Diagnostics table between focusing optics



THz streak camera / Spectral encoding







Pavle Juranic



Instrument overview







- Experiment preparation
 - FEL compatibility of experiment (expected sensitivity, sample damage, etc.)
 - Feasibility and preparation measurements
 - Requirements for sample environment, pump laser, FEL beam parameters
 - Data access and treatment software